



Article Studies of Performance of $Cs_2TiI_{6-X}Br_X$ (Where x = 0 to 6)-Based Mixed Halide Perovskite Solar Cell with CdS Electron Transport Layer

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Abstract: The present research work represents the numerical study of the device performance of a lead-free $Cs_2TiI_{6-X}Br_X$ -based mixed halide perovskite solar cell (PSC), where x = 1 to 5. The open circuit voltage (V_{OC}) and short circuit current (J_{SC}) in a generic TCO/electron transport layer (ETL)/absorbing layer/hole transfer layer (HTL) structure are the key parameters for analyzing the device performance. The entire simulation was conducted by a SCAPS-1D (solar cell capacitance simulator- one dimensional) simulator. An alternative FTO/CdS/Cs₂TiI_{6-X}Br_X/CuSCN/Ag solar cell architecture has been used and resulted in an optimized absorbing layer thickness at 0.5 µm thickness for the Cs₂TiBr₆, Cs₂TiI₁Br₅, Cs₂TiI₂Br₄, Cs₂TiI₃Br₃ and Cs₂TiI₄Br₂ absorbing materials and at 1.0 µm and 0.4 µm thickness for the Cs₂TiBr₆, Cs₂TiI₅Br₁ and Cs₂TiI₁Br₅ and Cs₂TiI₂Br₄ absorbing layers and at 20 °C for the Cs₂TiI₄Br₃, Cs₂TiI₄Br₂, Cs₂TiI₅Br₁ and Cs₂TiI₆ absorbing layers. The defect density was optimized at 10¹⁰ (cm⁻³) for all the active layers.

Keywords: perovskite; solar cell; diffusion; efficiency

1. Introduction

A solar cell is made for the conversion of solar energy into electrical energy directly, which has undergone continuous development from the past few years due to its superior photovoltaic (PV) properties. Initially, 1st generation wafer-based PV technology was developed but the production cost was relatively higher with lower conversion ability. The production cost became lower after the introduction of thin film-based 2nd generation solar cells, but still the power conversion efficiency (PCE) remained low. However, the problems including cost and PCE were nullified after the development of thin film-based 3rd generation PV technology. Perovskite solar cells (PSCs) have a great capability towards photovoltaic applications and are rapidly emerging as 3rd generation solar cells [1,2]. The journey started with Kojima et al. 2009, with halide perovskite ABM₃ (A: organic CH₃NH₃⁺;



Citation: Chakraborty, K.; Medikondu, N.R.; Duraisamy, K.; Soliman, N.F.; El-Shafai, W.; Lavadiya, S.; Paul, S.; Das, S. Studies of Performance of $Cs_2TiI_{6-X}Br_X$ (Where x = 0 to 6)-Based Mixed Halide Perovskite Solar Cell with CdS Electron Transport Layer. *Micromachines* 2023, 14, 447. https://doi.org/10.3390/mi14020447

Academic Editor: Sadia Ameen

Received: 1 January 2023 Revised: 6 February 2023 Accepted: 7 February 2023 Published: 14 February 2023



Copyright: © 2023 by the authors. Licensee MDPI, Basel, Switzerland. This article is an open access article distributed under the terms and conditions of the Creative Commons Attribution (CC BY) license (https:// creativecommons.org/licenses/by/ 4.0/). B: Pb, M: Br, I), and they recorded 3.8% of power conversion efficiency (PCE, %) [1]. Later, Yang et al. 2015, and Yin et al. 2015 further carried out extensive research on material, deposition process, fabrication methods and device structure that enhanced the PCE up to 20.1% experimentally, and theoretically 31.4% [3,4]. Hosseini et al. 2022 showed the effect of non-ideal conditions on lead-based CH₃NH₃PbI₃ perovskite material [5]. Despite the higher conversion efficiency in the laboratory, it has several issues in terms of commercialization such as environment protection from the toxic lead (Pb) component, and stability under environment conditions due to the organic component used in the ABM₃ structure. To address such issues, researchers considered using lead-free inorganic material as the absorbing material for the photovoltaic applications. Titanium (Ti)-based PSCs were introduced by Ju et al. 2018 with 1.0–1.8 eV tuneable band gap, and Chen et al. (2018) achieved 1.02 V open circuit voltage (V_{OC} , V), 5.69 mA/cm² current density (J_{SC} , mA/cm²) and 56.4% fill factor (FF, %) with Cs₂TiBr₆ absorbing material [6,7]. Shyma et al. 2022 employed SCAPS-1D-based simulation on Sn-based perovskite material CH₃NH₃SnI₃ to investigate the various parameters of the active materials and the selection of the appropriate ETL (electron transport layer) for the device [8]. On the other side, Omarova et al. 2022 showed the selection of the optimal HTL (hole transport layer), and also determined that electrodes can minimize the effects of material defects to improve the device performance [9].

By taking the knowledge from the above discussion, our research article has pinpointed several vital contributions including developing a theoretical model of a lead-free mixed halide FTO/CdS/Cs₂TiI_{6-X}Br_X /CuSCN/Ag-based structure where all the materials used for the SCAPS simulation are inorganic in nature, and then important physical, opto-electronic parameters such as thickness of material, device temperature and defect density of the material are optimized. For this optimization, we have analyzed the device performance parameter PCE with the variation in thickness of the active materials, followed by the device performance with the device temperature and defect density.

2. Device Architecture and Simulation

In our proposed FTO/CdS/Cs₂TiI_{6-X}Br_X/CuSCN/Ag-based planar solar cell device model, the band gap of ETL (electron transport layer) materials, CdS and HTL material CuSCN are taken to be 2.4 eV, 3.26 eV and 3.4 eV, respectively, and the absorbing layer is tuneable under 1.0-1.78 eV [10-15]. The working temperature for the simulation is maintained at 27 $^{\circ}$ C with -0.8 V to 0.8 V bias voltage in the SCAPS-1D simulator. Here, Figure 1 shows the schematic view of the proposed structure. the simulation is carried out with illumination of AM 1.5 with the light power of 1000 W/m^2 under Gaussian energy distribution, and its characteristic energy is set to 0.1 eV. With Br doping the lattice parameter, band structure and the optical properties of Cs_2TiI_6 can be changed. Thus, due to the doping effect, both Cs₂TiI₂Br₄ and Cs₂TiI₃Br₃ are suitable for solar cell applications. On the other side, based on the superior optical coincidence index and better absorption coefficient, $Cs_2TiI_2Br_4$ and Cs_2TiIBr_5 are ideal for light harvesting applications [16]. The details of the device materials' properties and active materials' basic parameters taken for the work are shown in Tables 1 and 2, respectively. The symbols, i.e., E_g , denote the band gap energy; χ is the electron affinity; \mathcal{E}_r is the relative permittivity; N_A is the acceptor density; N_D is the donor density; N_t is the total defect density; N_C is the conduction band effective density of states; N_V is the valence band effective density of states, respectively. The default values of some parameters and settings are as follows: electron mobility is $4.4 \text{ cm}^2/V_s$, hole mobility is $2.5 \text{ cm}^2/\text{V}_s$ and electron and hole thermal velocity is 10^7 cm/s [17]. The Shockley–Queisser limit of a perfect photovoltaic absorbing material is around 1.3 eV [16]. Our $Cs_2TiI_{6-X}Br_X$ -based active material has a band gap in the range of 1.07 to 1.78 eV which can be seen in Table 1.



Figure 1. Schematic view of the proposed solar cell structure.

Table 1. Device material properties.

Properties	CuSCN	CdS	FTO
Thickness (µm)	0.35	0.50	0.1
Eg (eV)	3.40	2.40	3.60
E _a (eV)	1.90	4.18	4.0
Er	9.0	10.0	9.0
$N_{D} (1/cm^{3})$	0	$1 imes 10^{15}$	$2.4 imes10^{18}$
$N_{\rm A} (1/{\rm cm}^3)$	$1 imes 10^{18}$	0	$1 imes 10^5$
$\mu_n (cm^2/V_S)$	$2 imes 10^{-4}$	100	100
$\mu_p \ (cm^2/V_S)$	$1 imes 10^{-2}$	25	25

Table 2. Basic parameters' properties.

Properties	$Cs_2TiI_1Br_5$	$Cs_2TiI_2Br_4$	Cs ₂ TiI ₃ Br ₃	$Cs_2TiI_4Br_2$	$Cs_2TiI_5Br_1$	Cs ₂ TiBr ₆	Cs ₂ TiI ₆
Thickness (µm)	0.3–4	0.3–4	0.3–4	0.3–4	0.3–4	0.3–4	0.3–4
Band gap, E _g (eV)	1.58	1.38	1.26	1.15	1.07	1.78	1.65
Electron affinity, Ea (eV)	3.42	3.62	3.74	3.85	3.93	4.47	4.20
Relative permittivity, Er	10	19	22	25	28	10	18
Donor density, N_D (1/cm ³)	$1 imes 10^{19}$	$2 imes 10^{19}$	$1 imes 10^{18}$	$5 imes 10^{18}$	$5 imes 10^{18}$	$1 imes 10^{19}$	$9 imes 10^{18}$
Acceptor density, N_A (1/cm ³)	$1 imes 10^{19}$	$2 imes 10^{19}$	$1 imes 10^{18}$	$5 imes 10^{18}$	$5 imes 10^{18}$	$1 imes 10^{19}$	$9 imes 10^{18}$
Electron mobility, μ_n (cm ² /V _S)	4.4	5.4	5.8	7.8	7.8	4.4	8.4
Hole mobility, μ_p (cm ² /V _S)	2.5	2.9	3.1	3.9	3.9	2.5	4.3

3. Results and Discussion

3.1. Optimization of Absorbing Layer Thickness with CdS Layer

In this section, the optimization of thickness of different perovskite absorbing layers such as Cs₂TiBr₆, Cs₂TiI₁Br₅, Cs₂TiI₂Br₄, Cs₂TiI₃Br₃, Cs₂TiI₄Br₂, Cs₂TiI₅Br₁ and Cs₂TiI₆ has been studied at 27 °C temperature with standard defect density (~1014 cm⁻³) and a constant series resistance [18] by varying the thickness from 0.3 to 3.0 μ m. Here, Figure 2a–c represent the PCE; a J-V graph with the thickness variation as 0.3 μ m, 0.4 μ m, 0.5 μ m, 1.0 μ m, 1.5 μ m, 2.0 μ m, 2.5 μ m, 3.0 μ m, 3.5 μ m and 4.0 μ m for the Cs₂Ti–_{6–X}Br_X perovskite solar cell; and PCE with the back contacts' metal work function. Generally, the lower thickness of

absorbing material leads to a low absorption of sunlight, which has a direct impact on PCE. From Figure 2a,b, it is observed that after 0.5 μ m thickness for the Cs₂TiBr₆, Cs₂TiI₁Br₅, Cs₂TiI₂Br₄, Cs₂TiI₃Br₃ and Cs₂TiI₄Br₂, and after 1.0 μ m thickness for the Cs₂TiI₅Br₁ and 0.4 μ m thickness for the Cs₂TiI₆ absorbing layer, the PCE of the device cell starts to fall gradually. The reason behind this fall is due to the increment in thickness of the absorbing layer as the light absorption rate becomes much higher. Such excess light absorption leads to a temperature rise in the device, and thus V_{OC} starts to fall drastically due to this temperature rise [12]. With the drop in V_{OC}, the PCE of the device starts to decrease. We all are aware that the PCE is a key parameter to evaluate the total annual power generation of a perovskite solar cell device-based PV (photovoltaic) module. Thus, reducing the PCE will decrease the maximum generated power (P_{MAX}) in the device. Despite the V_{OC} starting to fall with thickness, the generation rate of the charge carrier increases, which has a direct impact on the enhancement of J_{SC} [19]. Such an enhancement in J_{SC} will increase the Shockley–Read–Hall (SRH) recombination [20,21]. This phenomenon could establish a V_{OC}–J_{SC} relationship in the PV module [20–22].

$$V_{OC} = \frac{nKT}{q} ln \left(\frac{J_{SC}}{I_0} + 1 \right)$$
(1)

where T = device temperature, I_0 = reverse saturation current, q = electronic charge, n = ideality factor and K = Boltzmann constant.

From Equation (1), it is shown that the V_{OC} starts to fall as the reverse saturation current (I₀) increases in the device. Therefore, by analyzing all the parameters we may conclude that the Cs₂TiBr₆, Cs₂TiI₁Br₅, Cs₂TiI₂Br₄, Cs₂TiI₃Br₃ and Cs₂TiI₄Br₂ materials are optimized at 0.5 μ m; the Cs₂TiI₅Br₁ material is optimized at 1.0 μ m; and the Cs₂TiI₆ material is optimized at 0.4 μ m.

From Figure 2c it is observed that the PCE increases with the higher metal work function of the Ag paste up to a certain work function value (5 eV). The reason behind such an increment in the work function value is the decrement of the height of the carrier barrier, and as a result, the metal contact becomes ohmic in nature [8]. Thus, open circuit voltages also increase.

On the other hand, Figure 3a,b indicate the changes in diffusion length (L_n) with the voltage variation at the ambient temperature (300 K). As per the observations, the diffusion length increases with the open circuit voltage (V_{OC}) for all the seven absorbing materials except for $Cs_2TiI_5Br_1$ and Cs_2TiI_6 , where the diffusion length decreases after 0.6 V. The concentrations of electrons and holes are enhanced with the voltage which leads to an increment in diffusion length. The diffusion length of the electrons and holes should be higher than the absorbing layer thickness [8], since Cs_2TiI_6 , $Cs_2TiI_1Br_5$ and Cs_2TiI_6 absorbing materials have a band gap above 1.50 eV which requires large energy to excite an electron in the conduction band. Thus, such materials operate in a higher temperature which can burn the device after a certain temperature. Therefore, despite the better power absorption and power generation capability of Cs_2TiBr_6 , $Cs_2TiI_1Br_5$ and Cs_2TiI_6 absorbing material, they are not suitable for PV application.

3.2. Optimization of Device Temperature with CdS Layer

In our study, we have varied the temperature from -10 °C (263 K) to 100 °C (373 K) at an optimized thickness (Cs₂TiBr₆ = 0.5 µm, Cs₂TiI₁Br₅ = 0.5 µm, Cs₂TiI₂Br₄ = 0.5 µm, Cs₂TiI₃Br₃ = 0.5 µm, Cs₂TiI₄Br₂ = 0.5 µm, Cs₂TiI₅Br₁ = 1.0 µm and Cs₂TiI₆ = 0.4 µm) for the FTO/CdS/Cs₂Ti-_{6-X}Br_X /CuSCN device structure. Here, Equation (1) can be rewritten as follows [23,24]:

$$V = \frac{K_B T}{q} \log \left(\frac{r^{if}}{r_0^{if}}\right)$$
(2)

where $V = V_{OC}$, $r^{if} = I_{SC}$, $r_0^{if} = I_{0}$, n is the ideality factor, I_{SC} is the short circuit current and I_0 is the reverse saturation current.



Figure 2. Performance of $Cs_2Ti_{-6-X}Br_X$ absorbing layer with thickness variation for FTO/CdS/Cs₂Ti_{-6-X}Br_X/CuSCN/Ag structure: (a) PCE, (b) J-V plot and (c) electrical properties of metal work function.



Figure 3. Changes in diffusion length with the open circuit voltage: (a) electron, (b) hole.

From Equation (2) we can conclude that as the temperature starts to increase, the open circuit voltage (V_{OC}) will decrease accordingly. The prime reason behind such a decrement in V_{OC} is the exponential inverse increment in r_0^{if} in Equation (2), which leads to a similar exponential inverse increment in I_0 due to the temperature rise [12]. On the other hand, the temperature increment may cause the increment in the recombination process which will lead to the increment in the short circuit current (I_{SC}) [21]. Figure 4a,b show the changes in the PCE and V_{OC} with the device temperature for the absorbing materials and suggest that up to 40 °C, the V_{OC} increases quite significantly for the Cs_2TiBr_6 , $Cs_2TiI_1Br_5$ and $Cs_2TiI_2Br_4$ absorbing material, and after that temperature there is a significant change observed in the V_{OC} . Such a higher V_{OC} starts to increase the P_{MAX} . The reasons behind such peculiarities are the higher band gap of the Cs_2TiBr_6 (1.78 eV), $Cs_2TiI_1Br_5$ (1.58 eV) and $Cs_2TiI_2Br_4$ (1.38 eV) perovskite layers, and as the temperature starts to increase initially, the band gap of the materials starts to reduce, leading to a higher increment in the V_{OC} for the

 Cs_2TiBr_6 (1.78 eV) and $Cs_2TiI_1Br_5$ (1.58 eV) material. However, for the $Cs_2TiI_2Br_4$ material after 40 °C, V_{OC} starts to drop. On the other hand, $Cs_2TiI_3Br_3$, $Cs_2TiI_4Br_2$, $Cs_2TiI_5Br_1$ and Cs_2TiI_6 materials have a lower band gap. So, when the temperature starts to rise, the open circuit voltage (V_{OC}) starts to drop after 20 °C onwards despite the existence of almost constant J_{SC}. As a result, PCE and P_{MAX} after 20 °C start to reduce with the voltage drop. The same will be evidenced from Equation (2). This means as the temperature starts to rise, V_{OC} starts to decrease continuously and the back recombination process is begun. As a result, the PCE starts to fall gradually. So, from the above analysis, we may conclude that the optimal temperature for the Cs_2TiI_6 , $Cs_2TiI_1Br_5$ and $Cs_2TiI_2Br_4$ materials is 40 °C and for the $Cs_2TiI_3Br_3$, $Cs_2TiI_4Br_2$, $Cs_2TiI_5Br_1$ and Cs_2TiI_6 absorbing layers is 20 °C.



Figure 4. Device performance of $Cs_2Ti_{6-X}Br_X$ absorbing layer for the CdS ETL with temperature variation at optimized thickness: (a) PCE, (b) V_{OC} .

Similarly, changes in electron and hole diffusion length are depicted at 0 °C to 100 °C working temperature in Figure 5a,b. It can be observed that at a relatively higher temperature, the value of L_n is increasing simultaneously, as the diffusion length depends on the operating temperature and dopant concentration.



Figure 5. Changes in diffusion length with the working temperature: (a) electron, (b) hole.

3.3. Optimization of Defect Density

The total defect density plays a key role in determining the performance of a perovskite solar cell device, as it can debase the performance quality of the device. It has caused heavy charge recombination between the interfaces [25]. In our present study, we have changed the total defect density (N_t , cm⁻³) from 10^{10} to 10^{20} in the perovskite absorbing layer with a cell architecture of $FTO/CdS/Cs_2Ti_{6-\chi}Br_{\chi}/CuSCN$ to understand its effects on the device performances (PCE), and then tried to find out the optimum defect density for all the materials at the optimized thickness and temperature. It is observed that at a higher total defect density, there is a higher recombination of electron and hole pairs due to the generation of pinholes at the electrodes. Such a phenomenon reduces the stability of the device and overall performance of the device. The effects of defect density at the different interfaces are not included in this study. Here, Figure 6 shows the PCE variation with defect density for the $Cs_2Ti_{-6-X}Br_X$ absorbing layer with the CdS electron transport layer, respectively. So, from the above figures, it is clearly observed that the increment in defect density above 10^{10} cm⁻³ will reduce the PCE, respectively, for all the perovskite materials. We can also observe that for the Cs_2TiBr_6 absorbing material, the PCE decreases significantly with the defect density as it has a higher band gap as a result of the recombination rate starting to reduce. As a result, the collection of electron–hole pairs is also reduced and J_{SC} starts to decrease. Such changes result in the reduction of V_{OC} . The Cs₂TiI₁Br₅, Cs₂TiI₂Br₄, Cs₂TiI₃Br₃, Cs₂TiI₄Br₂, Cs₂TiI₅Br₁ and Cs₂TiI₆ materials have a continuous V_{OC} drop with J_{SC} reduction, and as a result the PCE falls. This incident signifies that at the higher total defect density, the back recombination process increases due to the impurities' enhancement in the absorbing materials, and as a result, conversion efficiency (PCE) loss starts to increase due to the V_{OC} and J_{SC} losses [24]. Such losses in the parameters will decrease the P_{MAX} for the absorbing layers which can be observed in Figure 6. So, from the above analysis of the performance parameters, the optimal defect density for the C–₂TiI_{6–X}Br_X absorbing layer with CdS ETL is 10¹⁰ cm⁻³. Hence, it can be concluded that the total defect density of the materials affects the PCE of the device as increasing defects imply reduction in the diffusion length of the electron and hole charge carriers.



Figure 6. PCE of $C_{-2}TiI_{6-X}Br_X$ absorbing layer with different defect densities at optimized thickness and temperature for CdS ETL.

4. Conclusions

This research article presents the optimization of the thickness of the absorbing layer with two different electron transport layers (CdS) numerically using the SCAPS simulator for the planar FTO/CdS/Cs₂TiI_{6-X}Br_X /CuSCN structure. The results indicate the performance of the device (PCE, V_{OC}) and maximum power conversion (P_{MAX}) are better between 0.5 and 1 µm. Through further observations, we have seen that optimization of the device temperature lies between 10 °C and 60 °C and defect densities between 10¹⁰ and 10¹⁴ cm⁻³ for the different absorbing materials. During the simulation process, it was observed that defect densities have a great impact on the charge recombination rate. This research work has not covered the recombination rate in different interfaces of the solar cell device, which include the ETL/perovskite and perovskite/HTL interfaces.

Author Contributions: Conceptualization: K.C., N.R.M., K.D. and S.P.; methodology: K.C., S.D., N.R.M., K.D. and S.P.; software: K.C., S.L., W.E.-S., K.D. and N.F.S.; validation: W.E.-S., S.D., N.R.M. and S.L.; writing—original draft preparation: K.C., S.D., K.D. and N.F.S.; writing—review and editing: S.L., S.P., N.R.M. and W.E.-S.; supervision: S.P. and S.D.; project administration: W.E.-S.; funding acquisition: N.F.S. All authors have read and agreed to the published version of the manuscript.

Funding: This work is supported by Princess Nourah bint Abdulrahman University Researchers Supporting Project number (PNURSP2023R66), Princess Nourah bint Abdulrahman University, Riyadh, Saudi Arabia. Institutional Review Board Statement: Not applicable.

Informed Consent Statement: Not applicable.

Data Availability Statement: The data presented in this research are available on request from the corresponding author.

Acknowledgments: The authors would like to acknowledge the Princess Nourah bint Abdulrahman University Researchers Supporting Project number (PNURSP2023R66), Princess Nourah bint Abdulrahman University, Riyadh, Saudi Arabia. The authors would like to acknowledge the support of Prince Sultan University for paying the Article Processing Charges (APC) of this publication.

Conflicts of Interest: The authors declare no conflict of interest.

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